

N-Channel 60 V (D-S) MOSFET

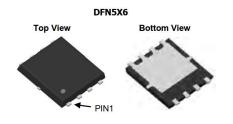
PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^a	Q _g (Typ.)	
80	7.8 at V _{GS} = 10 V	60	110nC	
	16 at V _{GS} = 7.5 V	60	TIONG	

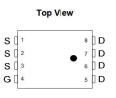
FEATURES

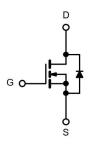
- DT-Trench Power MOSFET
- 100 % $\rm R_{\rm g}$ and UIS Tested

APPLICATIONS

- Notebook PC Core
- VRM/POL







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	80	V	
Gate-Source Voltage		V _{GS}	± 20]	
	T _C = 25 °C		60 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	52		
Continuous Diain Current (1) = 130 °C)	T _A = 25 °C		20 ^{b, c}	A	
	T _A = 70 °C		16 ^{b, c}	7	
Pulsed Drain Current		I _{DM}	180		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	30		
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	60	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	60 ^a	Α Α	
Continuous Cource-Drain Diode Current	T _A = 25 °C	.5	5 b, c		
	T _C = 25 °C		80 a		
Maximum Power Dissipation	T _C = 70 °C	P _D	51	w	
	T _A = 25 °C	טי	5 ^{b, c}		
	T _A = 70 °C		3 b, c		
Operating Junction and Storage Temperature Ran	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	15	18	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	1	1.5	- C/VV	

- Notes:
 a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
 c. t = 10 s.
 d. Maximum under steady state conditions is 65 °C/W.

Rev.B 1



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, V _{GS} = 0 V			1	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$ $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	70		10	Α	
on clate brain ourient	R _{DS(on)}	V _{GS} = 10 V, I _D = 20 A	1	7.8	8.5	R R	
Drain-Source On-State Resistance ^a		V _{GS} = 7.5 V, I _D = 15 A		16			
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 20 A		60		S	
Dynamic ^b							
Input Capacitance	C _{iss}			6400		pF	
Output Capacitance	C _{oss}	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz		300			
Reverse Transfer Capacitance	C _{rss}			360			
Total Gate Charge	Q_g			110		nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		20			
Gate-Drain Charge	Q _{gd}			35			
Gate Resistance	R_g	f = 1 MHz		1.2		Ω	
Turn-On Delay Time	t _{d(on)}			15			
Rise Time	t _r	$V_{DD} = 40 \text{ V}, R_L = 4\Omega$		9		ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		22			
Fall Time	t _f			5			
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			60	Α	
Pulse Diode Forward Current ^a	I _{SM}				180		
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1	V	
Body Diode Reverse Recovery Time	t _{rr}			21	30	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		70	100	nC	
Reverse Recovery Fall Time	t _a	1 - 20 /1, α//αt = 100 /1 μ3, 1 J = 20 0		18		ns	
Reverse Recovery Rise Time	t _b			20			

Notes:

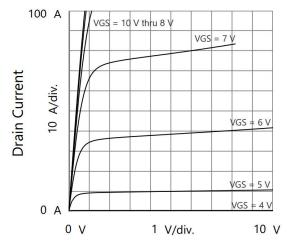
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

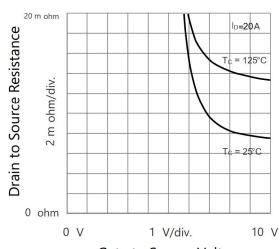
b. Guaranteed by design, not subject to production testing.



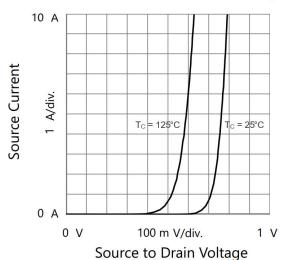
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



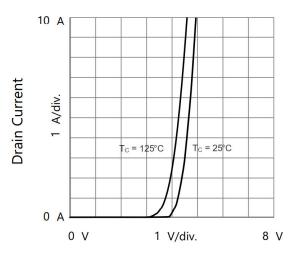
Drain to Source Voltage Output Characteristics



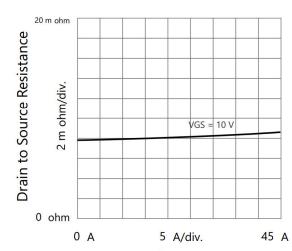
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage



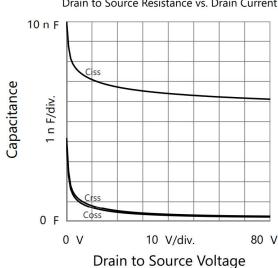
Body Diode Forward Characteristics



Gate to Source Voltage Transfer Characteristics



Drain Current
Drain to Source Resistance vs. Drain Current

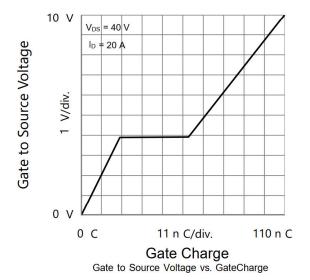


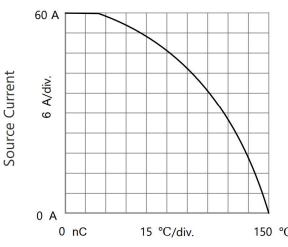
Drain to Source Voltage Capacitances

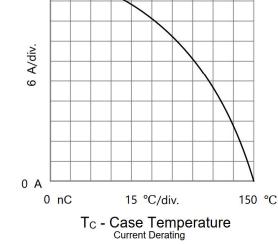


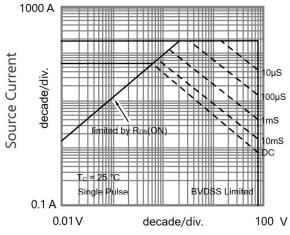
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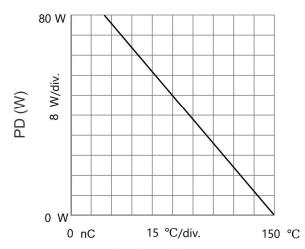




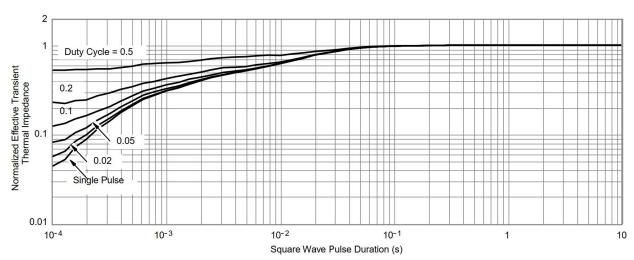




Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



 $T_{C} \textbf{ - Case Temperature} \\ \text{Power Derating}$



Normalized Thermal Transient Impedance, Junction-to-Case





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